

A Viable Copper Based Alternative to Pd Activation Systems for Electroless Copper Processing

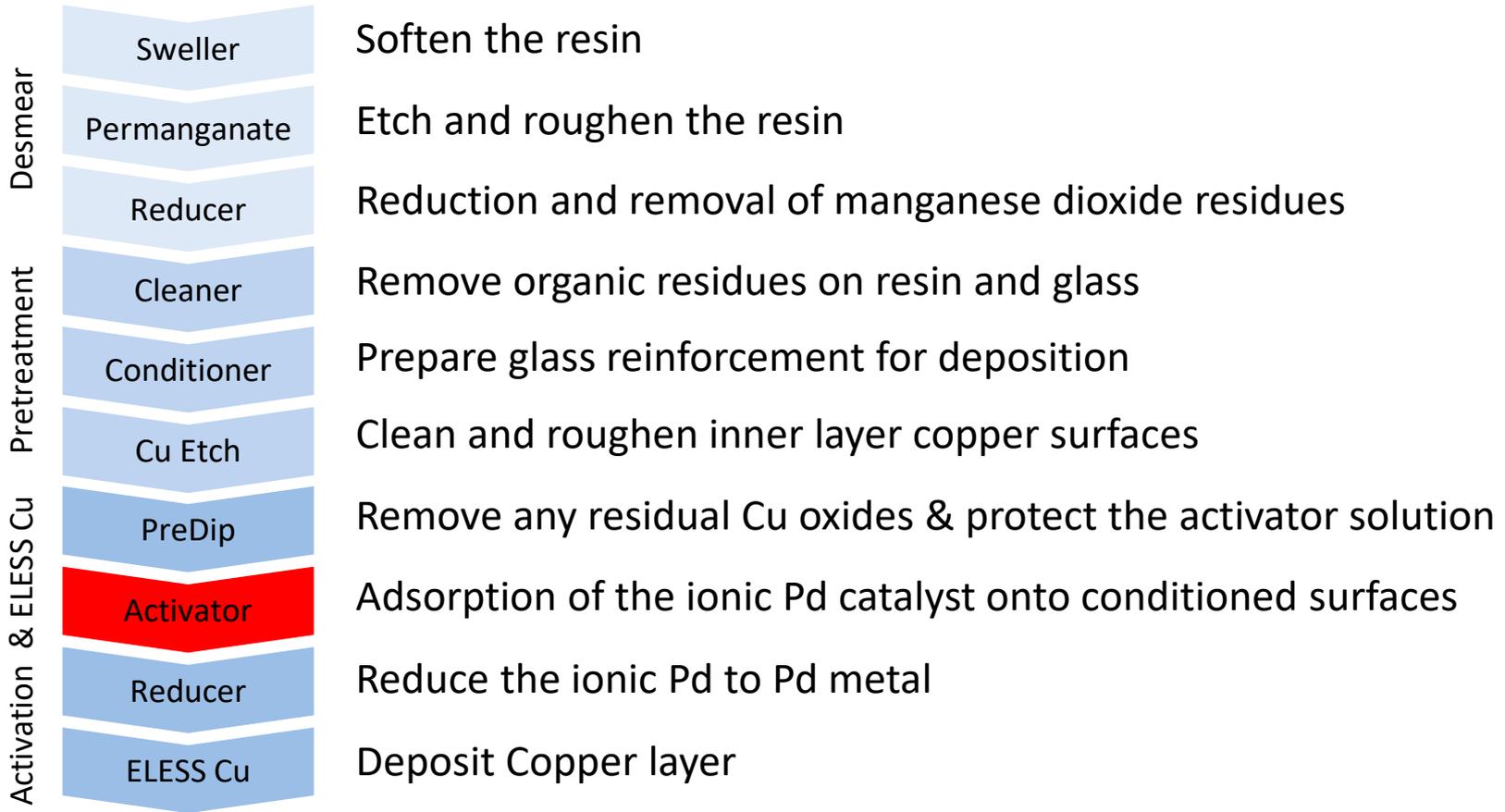
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Technology for tomorrow's solutions

Copper Based ELESS Activation

Electroless Copper Process Sequence

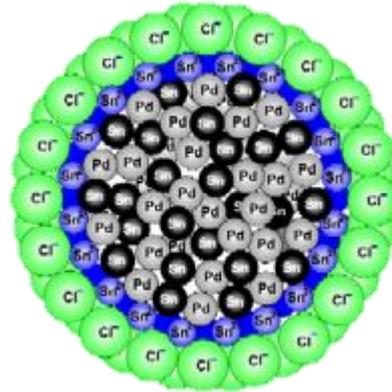


Copper Based ELESS Activation

Electroless Copper Activators

Pd - Sn Colloid

-  0.181 nm
-  0.128 nm
-  0.093 nm



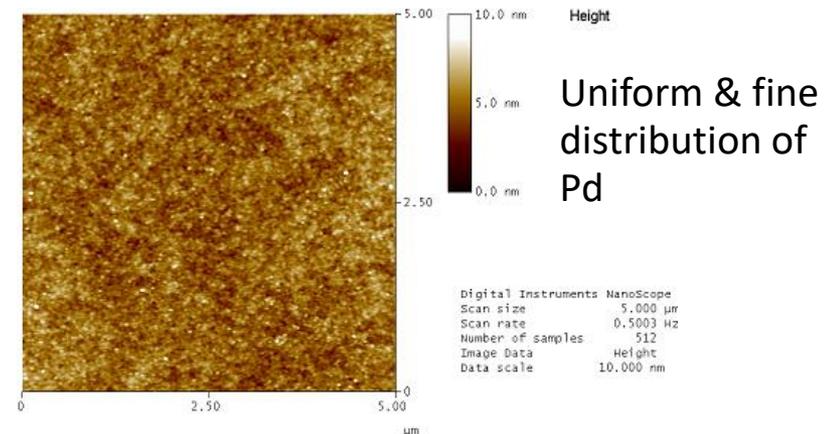
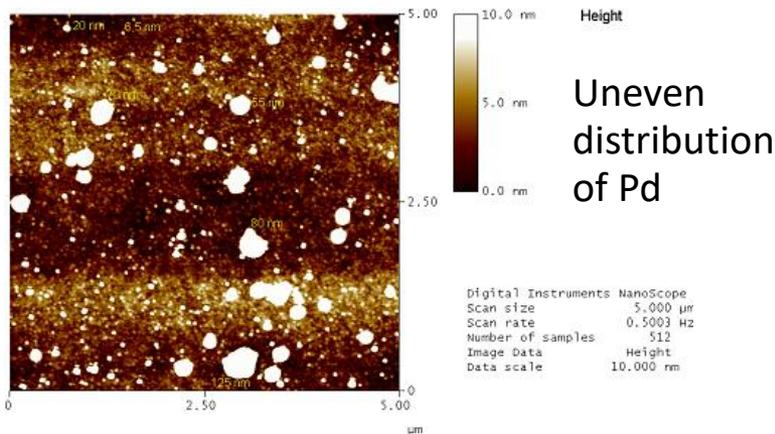
Colloid diameter
 Typ.: 2-10 nm
 Max 100 nm

Ionic Pd Complex

-  Organic chelator
-  0.128 nm



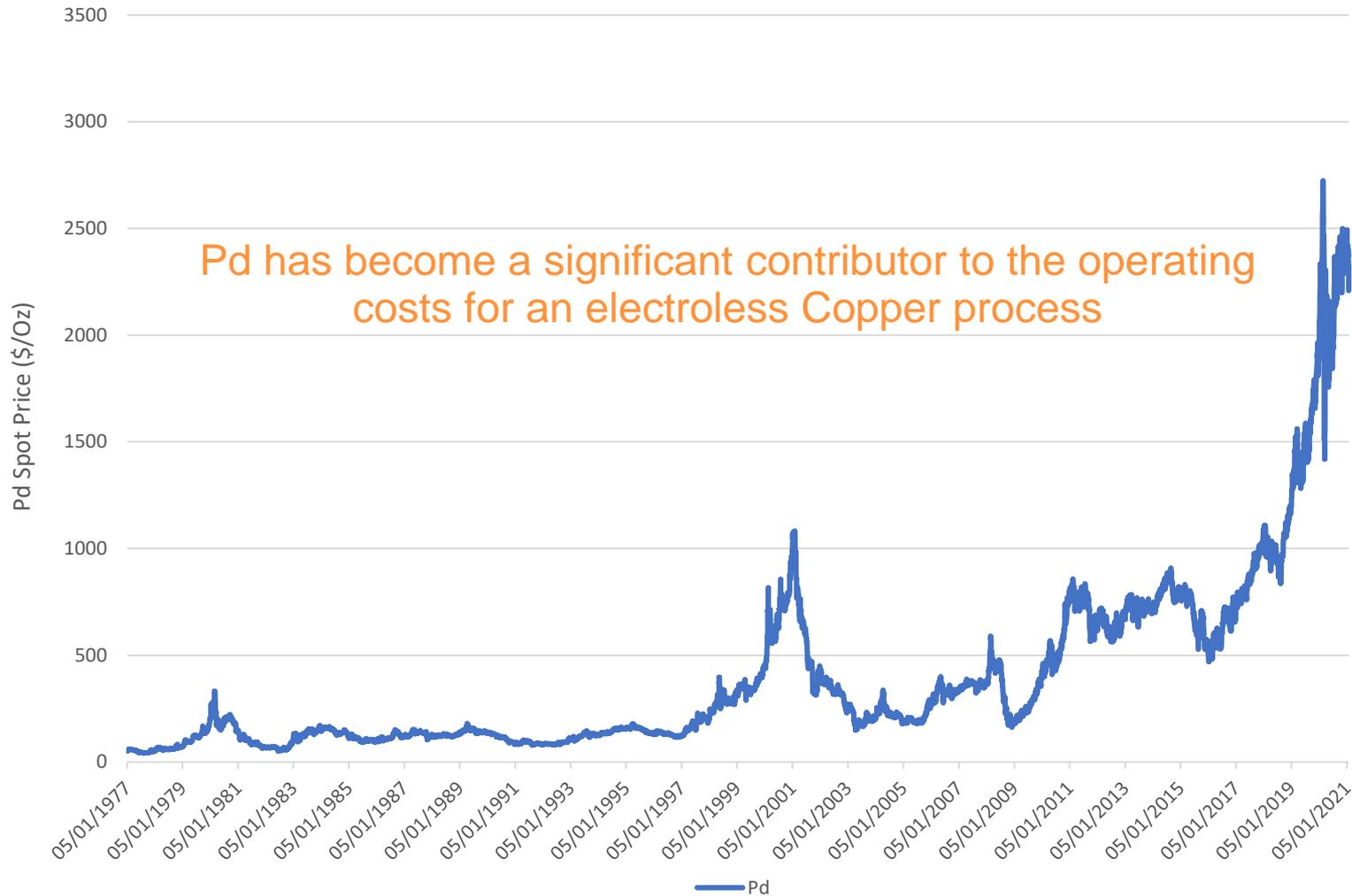
Cluster diameter
 Typ.: 1.0 nm



Copper Based ELESS Activation



Why Change a Good Thing?

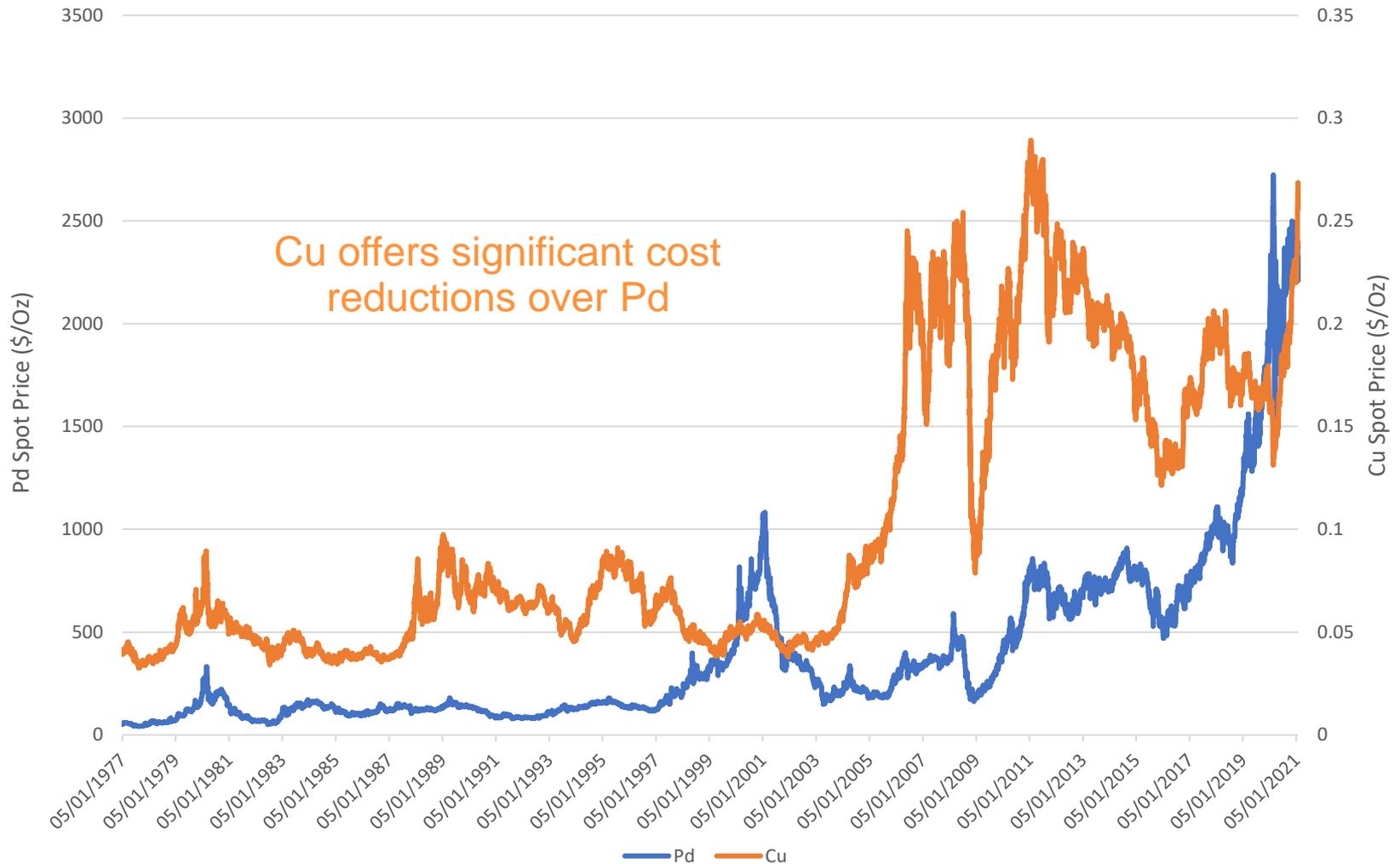


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Copper Based ELESS Activation



Why Change a Good Thing?



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Copper Based ELESS Activation

Why Change a Good Thing?

- Copper as an activator is not a new idea
- No production viable process available
 - Low bath stability – Activator precipitates rapidly
 - Poor resistance to rinsing – Activator washes off – poor coverage/adhesion
- Our focus has been on developing an activator solution based on colloidal Copper
- With a performance that is at least comparable to that of ionic palladium activation system

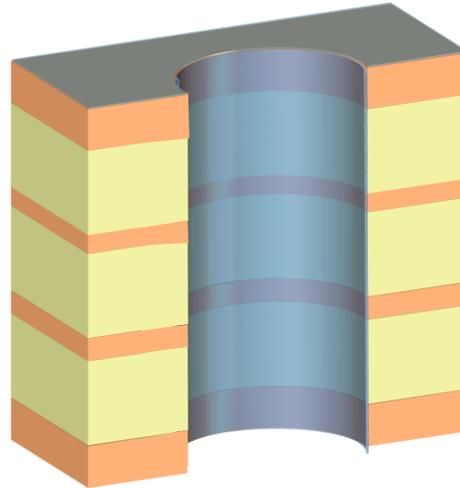
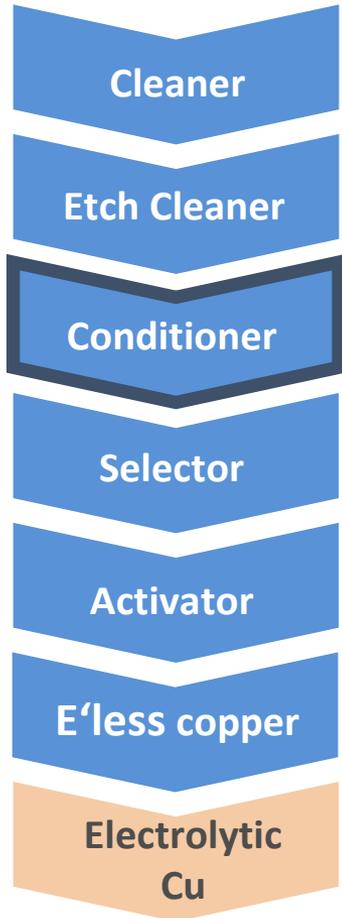
Copper Based ELESS Activation

Process Integration – Sequence

Process sequence	Ionic Pd Activation	Colloidal Cu Activation
Sweller	Sweller	
Desmear	Permanganate	
Reduction	Conditioner & Glass Conditioner	
Cleaner - 1	Cleaner	
Cleaner - 2	Cu Etch	
Activation - 1	PreDip	Conditioner
Activation - 2	Pd Activator	Selector
Activation - 3	Reducer	Activator
Electroless Copper	ELESS Cu	

Copper Based ELESS Activation

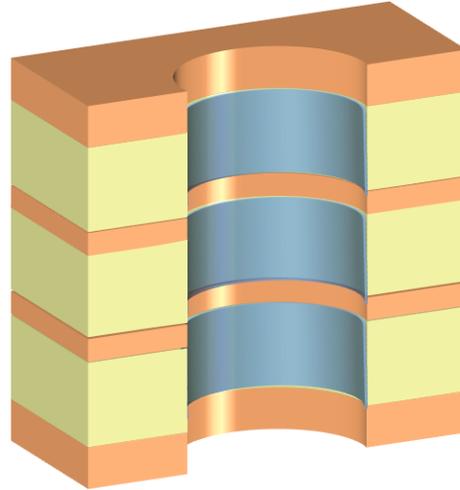
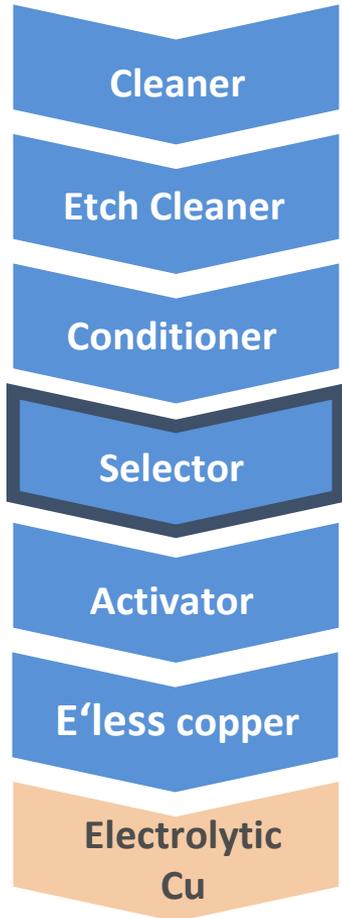
Process Integration – Conditioner



- Wetting and conditioning of the hole wall surface (resin and glass fibers) for best copper coverage by means of the Cu based activator.
- The conditioner is based on a unique highly functionalized polymer.

Copper Based ELESS Activation

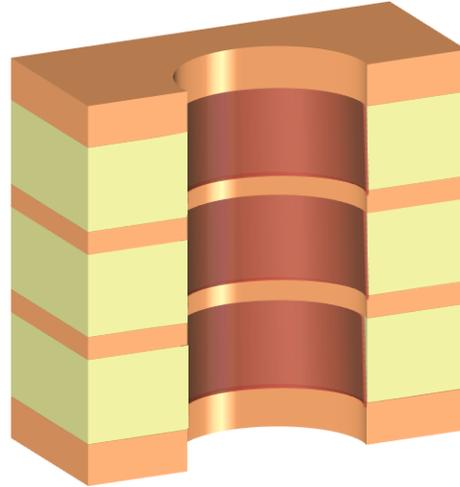
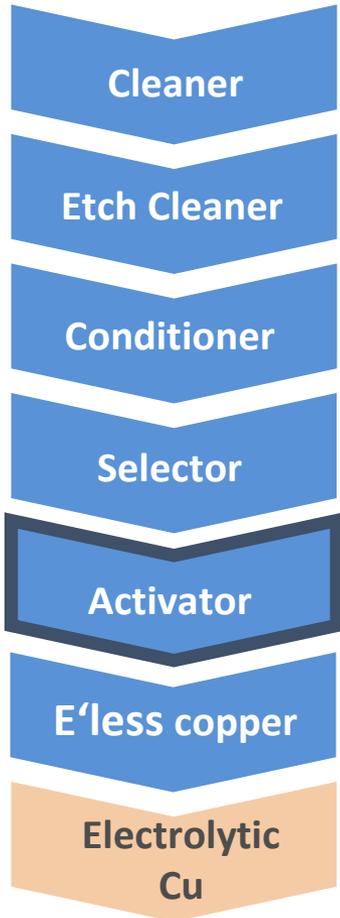
Process Integration – Selector



- Cleaning and removal of conditioner residues from copper surfaces to ensure an optimum Cu – Cu adhesion on inner layers

Copper Based ELESS Activation

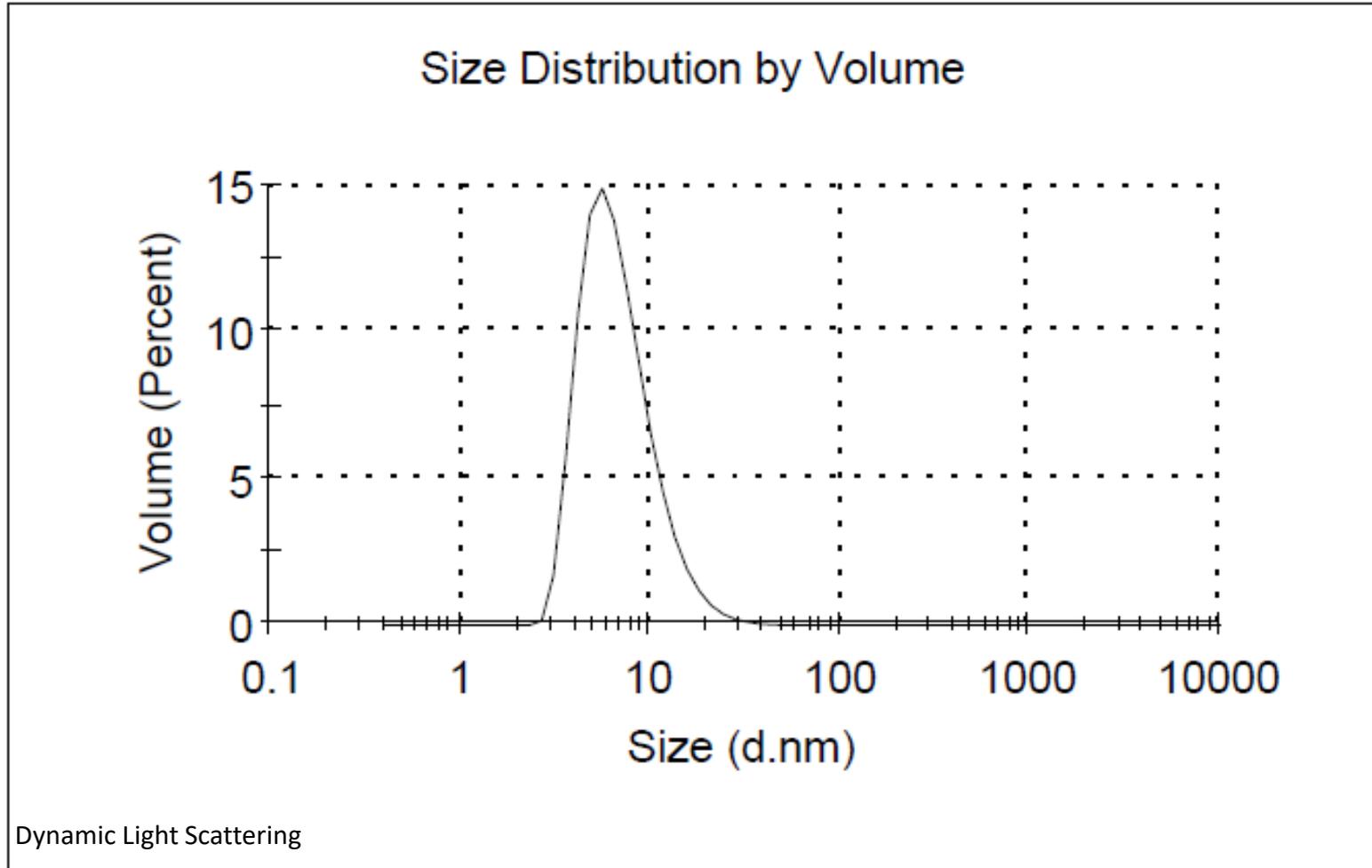
Process Integration – Activation



- Activator is entirely free of palladium.
- The copper activator is based on colloidal metallic copper particles of nanoscopic size.
- This formulation ensures a homogenous and dense coverage with copper seeds.

Copper Based ELESS Activation

Process Integration – Activator Colloid Particle Size



Copper Based ELESS Activation

Cu Colloid Activator – Make Up

- Novel make-up of the activator bath
- In-situ formation of Cu colloids
 - Mix
 - Analyze
 - Ready to go



Copper Based ELESS Activation

Cu Colloid Activator - Rinsing

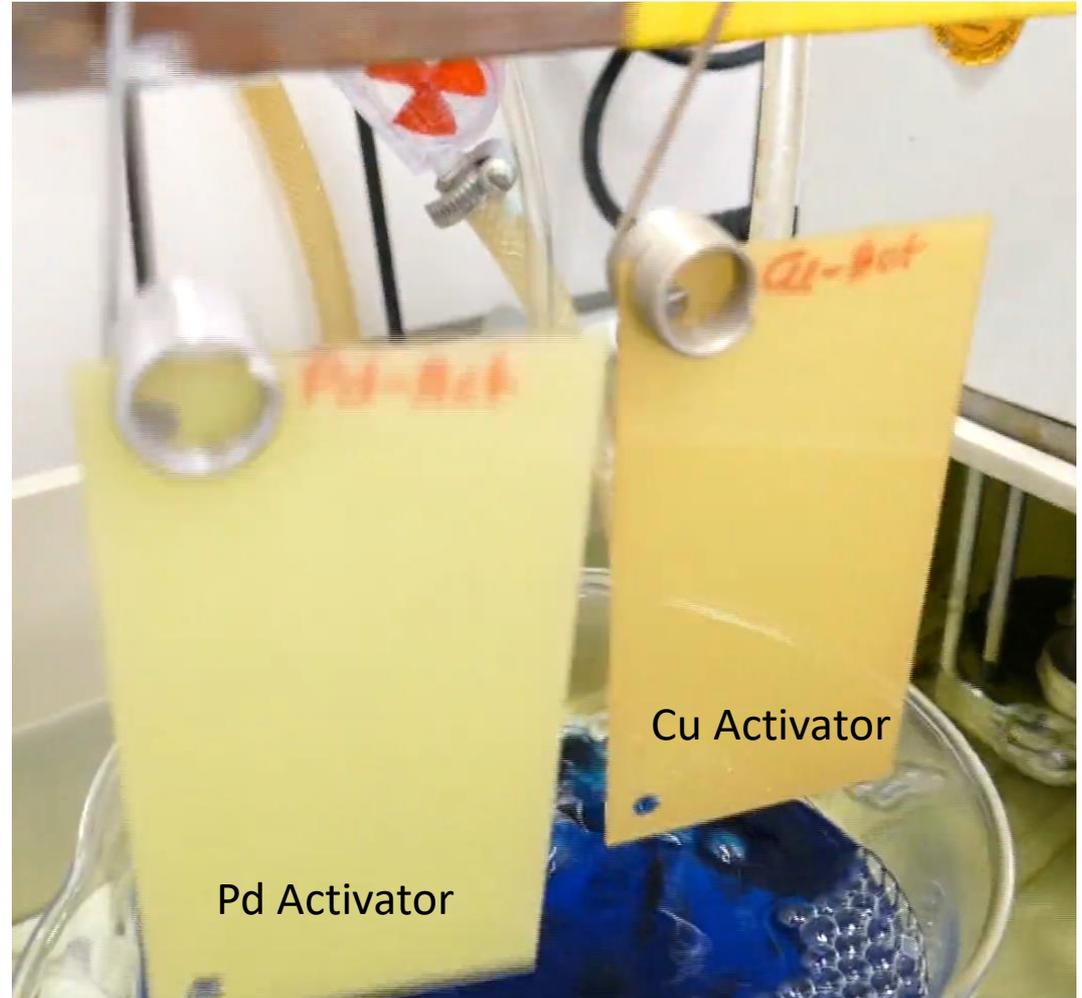
- The deposited Cu seed layer is robust enough to withstand vigorous rinsing.



Copper Based ELESS Activation

Cu Colloid Activator - Deposition

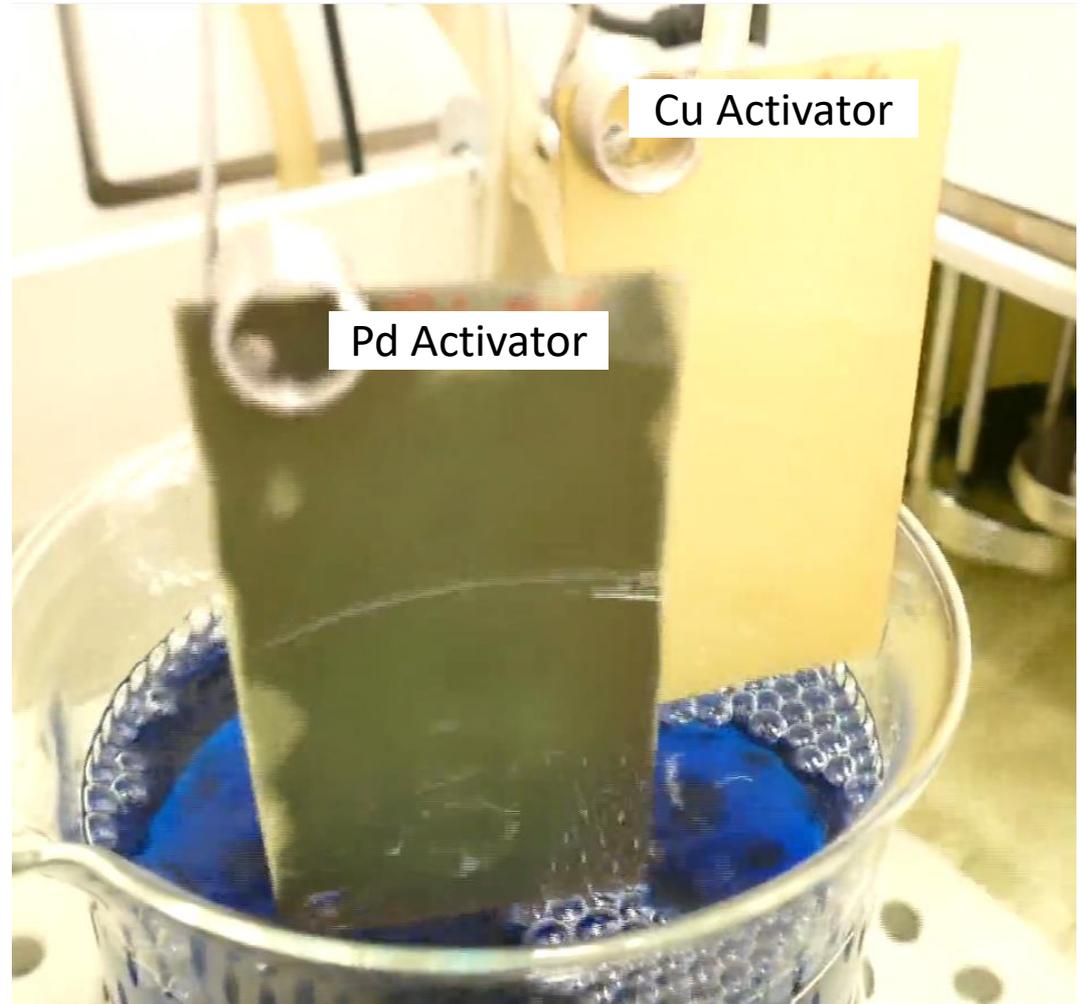
- Deposition of the Cu activator can be easily seen



Copper Based ELESS Activation

Cu Colloid Activator – Deposition of ELESS

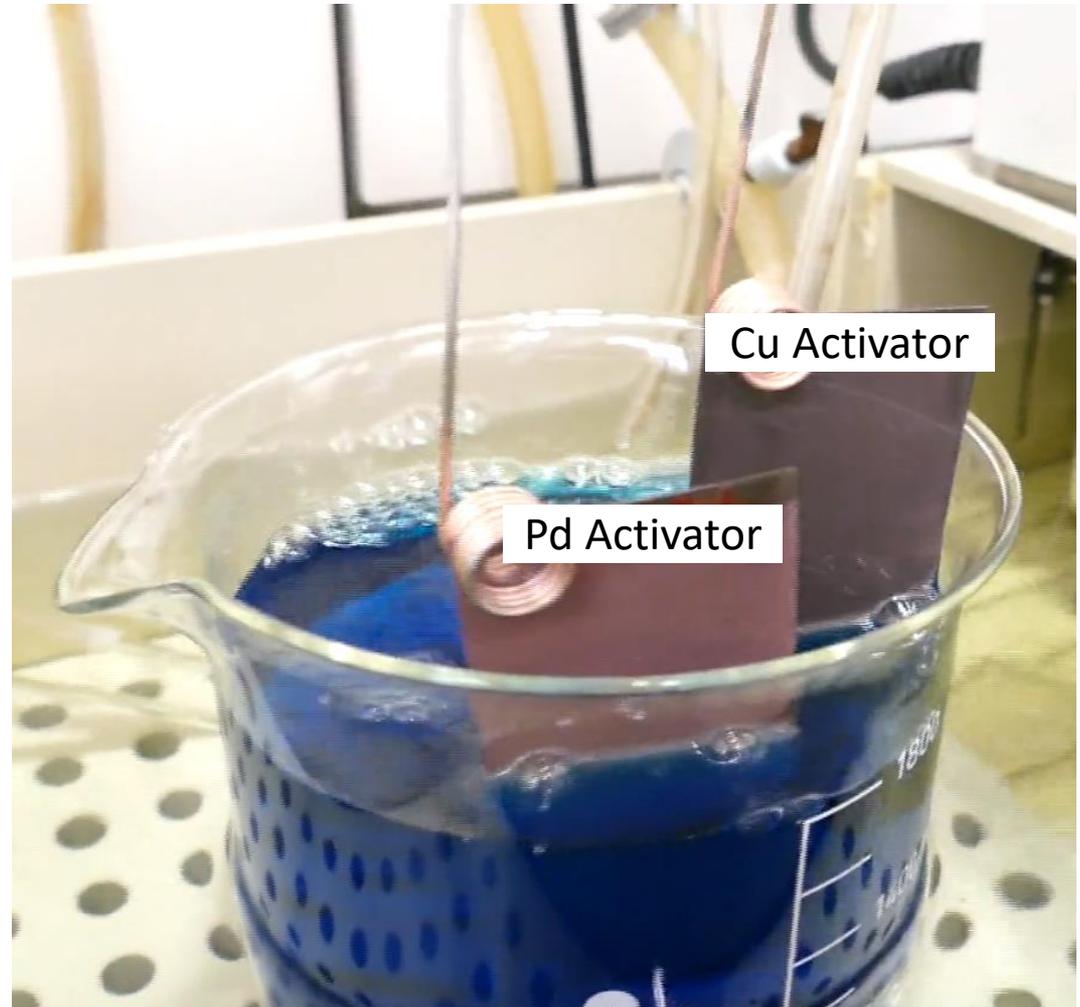
- Deposition appearance after 15 sec
 - Slower initiation with the Cu colloid



Copper Based ELESS Activation

Cu Colloid Activator – Deposition of ELESS

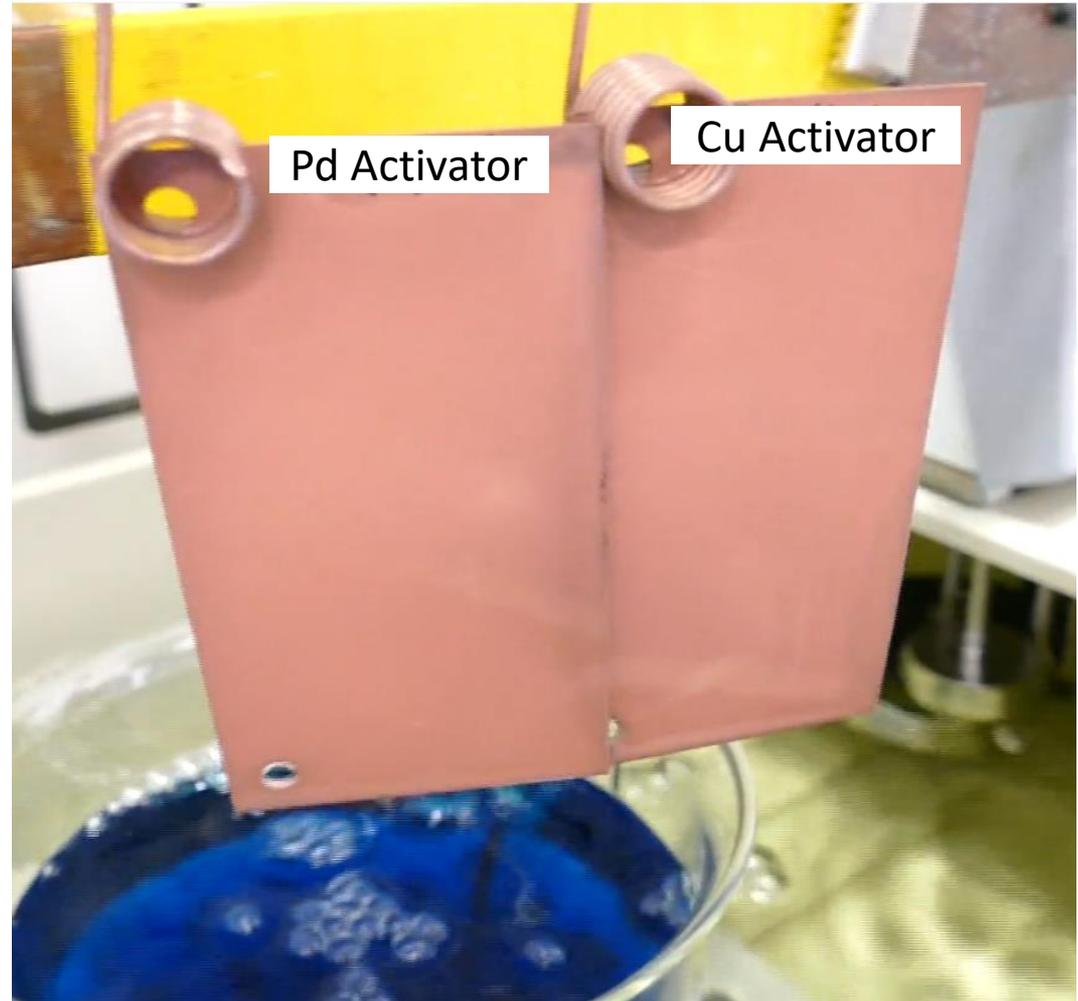
- Deposition appearance after 60 sec
- Now also the deposition of the Cu activator is catching up.



Copper Based ELESS Activation

Cu Colloid Activator – Deposition of ELESS

- Deposition appearance after 20 min
- Both coupons are fully plated and indistinguishable
- Deposition thickness for both samples measured at $1.0\ \mu\text{m}$



Copper Based ELESS Activation

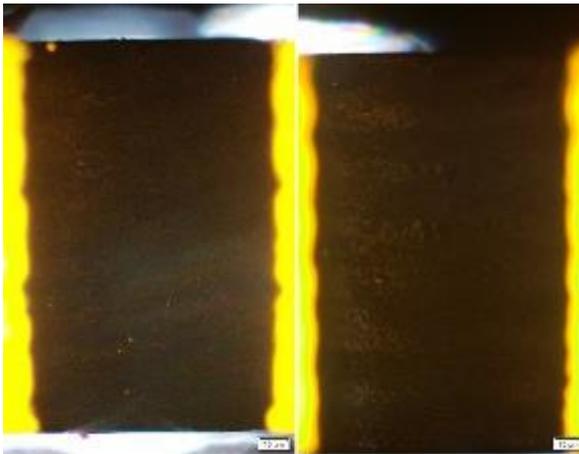
Cu Colloid Activator – Performance – Coverage

Ionic Pd
Activation

Colloidal Cu
Activation



Low/Mid T_g FR4
(140°C)

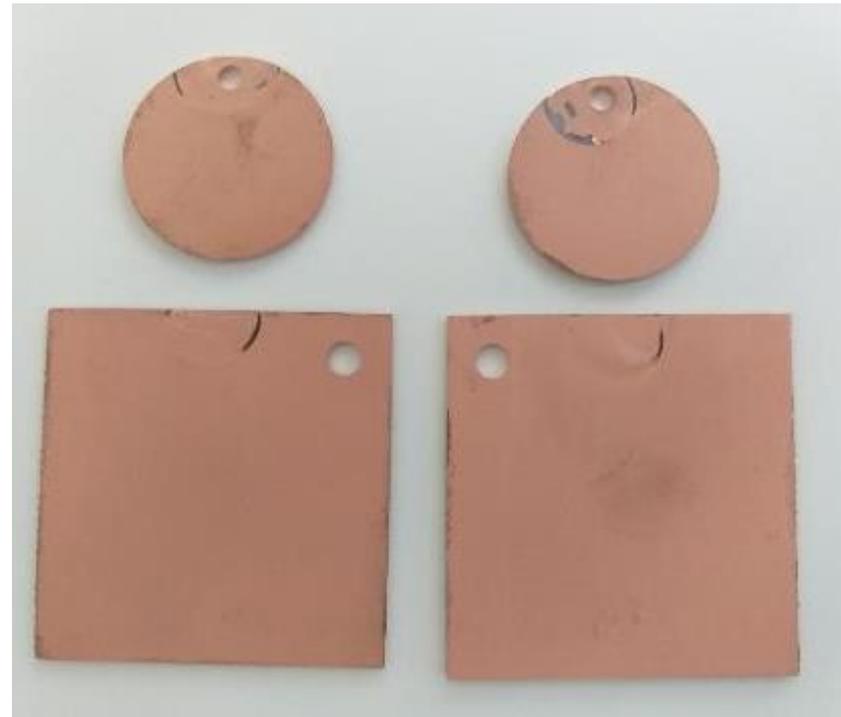


High T_g FR4
(180°C)

Comparable Coverage

Ionic Pd
Activation

Colloidal Cu
Activation



ABS

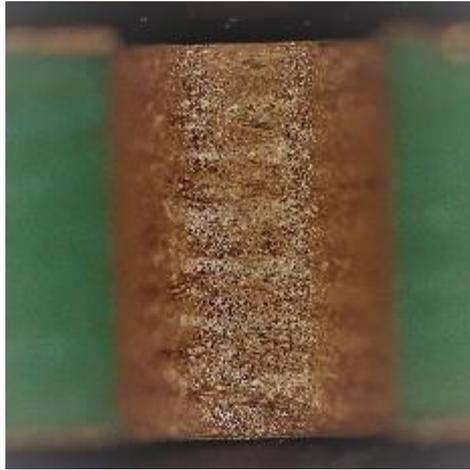
FR4

No Blistering on Bare Resin

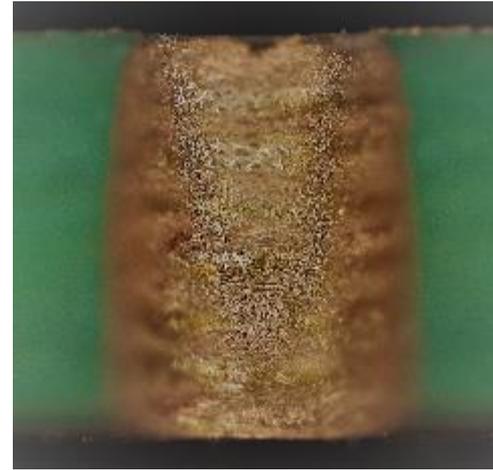
Copper Based ELESS Activation

Cu Colloid Activator – Performance – Coverage

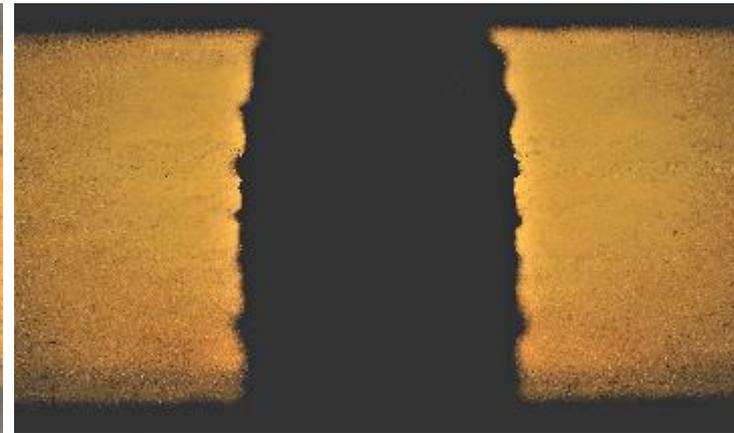
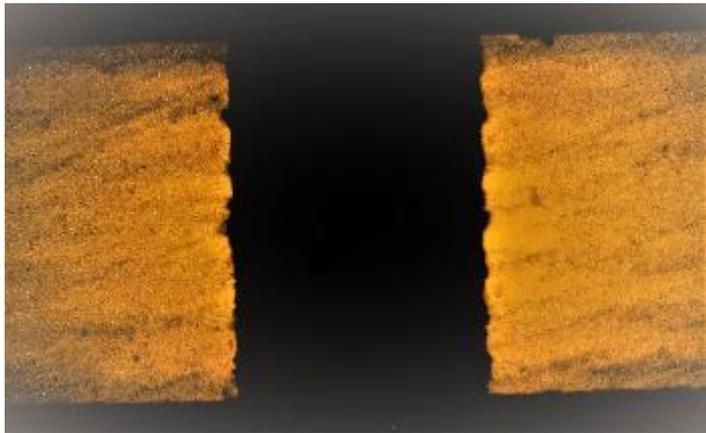
Ionic Pd Activation &
SAP ELESS Cu (20 min)



Colloidal Cu Activation &
SAP ELESS Cu (20 min)



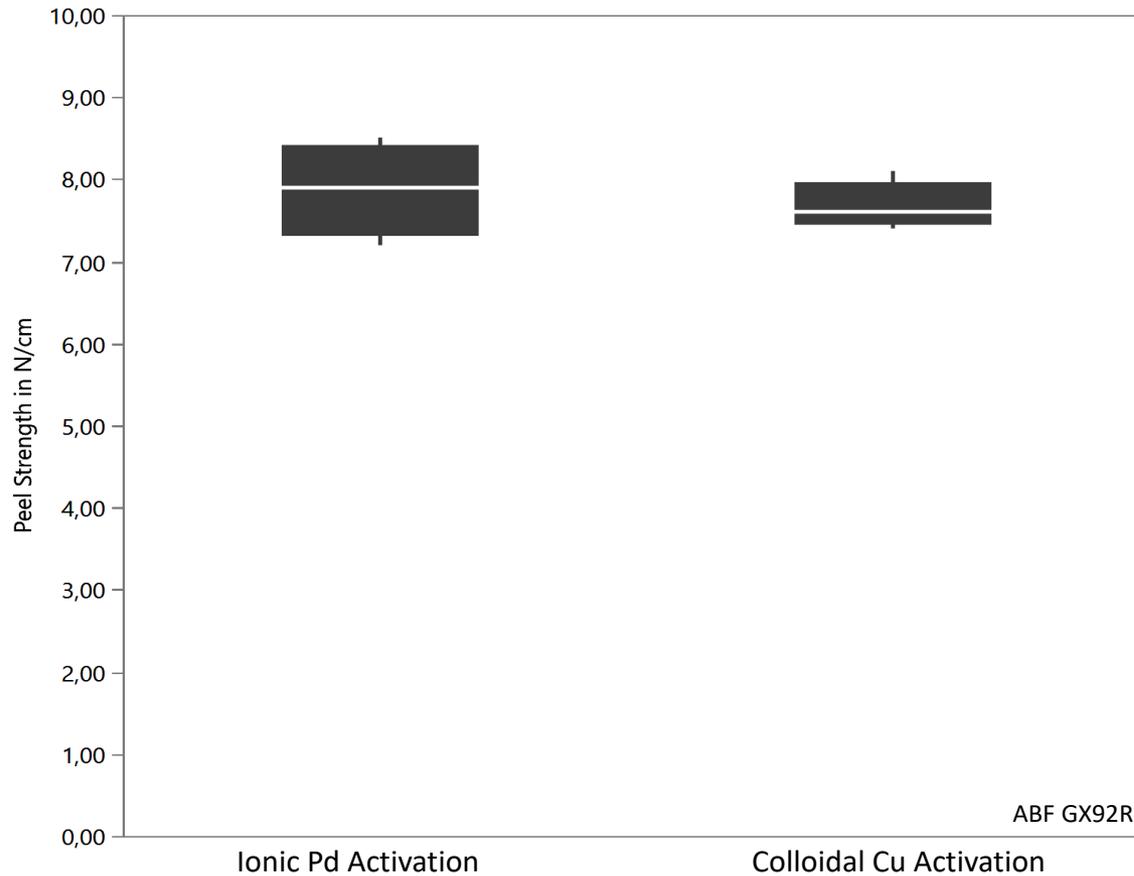
High T_g FR4
(180°C)



Comparable Coverage to Pd Based Process

Copper Based ELESS Activation

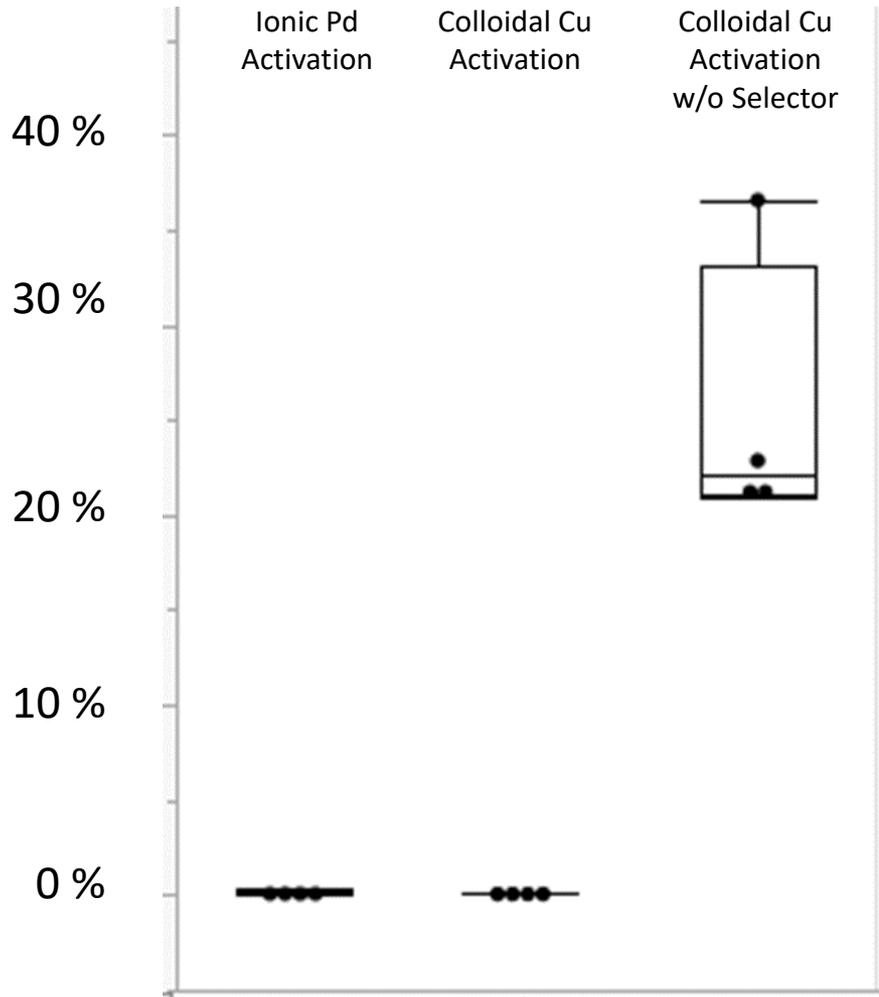
Cu Colloid Activator – Performance – Coverage



Comparable Adhesion to Pd Based Process

Copper Based ELESS Activation

Cu Colloid Activator – Performance – Thermal Reliability



- Comparable ICD performance to Ionic Pd Activation
- Unique Selector step is a must to achieve reliability performance

Copper Based ELESS Activation

Cu Colloid Activator – Benefits for SAP production



- The benefits of using Copper-activation for SAP applications
- Reduced CoO
- Simplified process flow
 - No need for additional Pd seed etch
 - Increased yields
 - Enhanced fine line capability

Copper Based ELESS Activation

Cu Colloid Activator – Summary



- Pd pricing continues to remain at an all time high
- A viable Cu based activation system is now achievable for SAP processing
 - Based on sub micron Cu colloids
- Overcomes previous encountered issues with bath stability and rinsing
 - Compatible with typical vertical process sequences
- Process performance is comparable to existing Pd based technologies
 - Coverage
 - ICD
- Benefits for SAP production
 - Reduced CoO, improved yields and enhanced fine line capability
- Further testing ongoing

Thanks for your attention



Technology for tomorrow's solutions